

October 1987 Revised March 2002

CD4001BC/CD4011BC Quad 2-Input NOR Buffered B Series Gate • Quad 2-Input NAND Buffered B Series Gate

General Description

The CD4001BC and CD4011BC quad gates are monolithic complementary MOS (CMOS) integrated circuits constructed with N- and P-channel enhancement mode transistors. They have equal source and sink current capabilities and conform to standard B series output drive. The devices also have buffered outputs which improve transfer characteristics by providing very high gain.

All inputs are protected against static discharge with diodes to $\rm V_{DD}$ and $\rm V_{SS}.$

Features

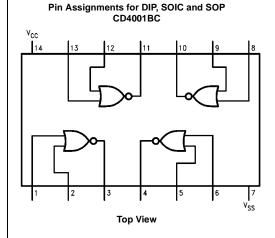
- Low power TTL: Fan out of 2 driving 74L compatibility: or 1 driving 74LS
- 5V-10V-15V parametric ratings
- Symmetrical output characteristics
- Maximum input leakage 1 µA at 15V over full temperature range

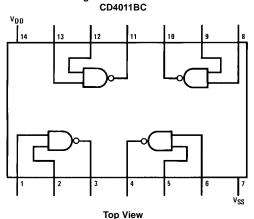
Ordering Code:

Order Number	Package Number	Package Description
CD4001BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4001BCSJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
CD4001BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
CD4011BCM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4011BCN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

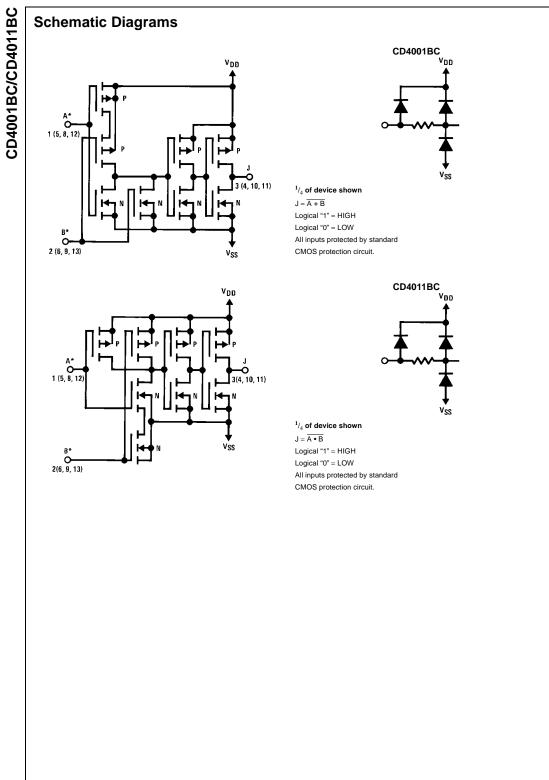
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams





Pin Assignments for DIP and SOIC



Absolute Maximum Ratings(Note 1)

(Note 2)

Voltage at any Pin $$-0.5\mathrm{V}$ to \ V_{DD}$ +0.5\mathrm{V}$$

Power Dissipation (P_D)

Dual-In-Line700 mWSmall Outline500 mW

 $\begin{array}{ll} V_{DD} \; Range & -0.5 \; V_{DC} \; to + 18 \; V_{DC} \\ Storage \; Temperature \; (T_S) & -65^{\circ}C \; to + 150^{\circ}C \end{array}$

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Recommended Operating Conditions

Operating Range (V_{DD}) 3 V_{DC} to 15 V_{DC}

Operating Temperature Range

CD4001BC, CD4011BC -55°C to +125°C

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The Electrical Characteristics tables provide conditions for actual device operation.

Note 2: All voltages measured with respect to $V_{\mbox{SS}}$ unless otherwise specified

DC Electrical Characteristics (Note 2)

Symbol	Parameter	Conditions	-55°C		+25°C			+125°C		Units
	Farameter	Conditions	Min	Max	Min	Тур	Max	Min	Max	Units
I _{DD}	Quiescent Device	$V_{DD} = 5V$, $V_{IN} = V_{DD}$ or V_{SS}		0.25		0.004	0.25		7.5	
	Current	$V_{DD} = 10V$, $V_{IN} = V_{DD}$ or V_{SS}		0.5		0.005	0.50		15	μΑ
		$V_{DD} = 15V$, $V_{IN} = V_{DD}$ or V_{SS}		1.0		0.006	1.0		30	
V _{OL}	LOW Level	$V_{DD} = 5V$		0.05		0	0.05		0.05	
	Output Voltage	$V_{DD} = 10V \qquad I_O < 1 \; \mu A$		0.05		0	0.05		0.05	V
		$V_{DD} = 15V$		0.05		0	0.05		0.05	
V _{OH}	HIGH Level	$V_{DD} = 5V$	4.95		4.95	5		4.95		
	Output Voltage	$V_{DD} = 10V \qquad I_O < 1 \; \mu A$	9.95		9.95	10		9.95		V
		$V_{DD} = 15V$	14.95		14.95	15		14.95		
V _{IL}	LOW Level	$V_{DD} = 5V, V_{O} = 4.5V$		1.5		2	1.5		1.5	
	Input Voltage	$V_{DD} = 10V, V_{O} = 9.0V$		3.0		4	3.0		3.0	V
		$V_{DD} = 15V, V_{O} = 13.5V$		4.0		6	4.0		4.0	
V _{IH}	HIGH Level	$V_{DD} = 5V, V_{O} = 0.5V$	3.5		3.5	3		3.5		
	Input Voltage	$V_{DD} = 10V, V_{O} = 1.0V$	7.0		7.0	6		7.0		V
		$V_{DD} = 15V, V_{O} = 1.5V$	11.0		11.0	9		11.0		
I _{OL}	LOW Level Output	$V_{DD} = 5V, V_{O} = 0.4V$	0.64		0.51	0.88		0.36		
	Current	$V_{DD} = 10V, V_{O} = 0.5V$	1.6		1.3	2.25		0.9		mA
	(Note 3)	$V_{DD} = 15V, V_{O} = 1.5V$	4.2		3.4	8.8		2.4		
I _{OH}	HIGH Level Output	$V_{DD} = 5V, V_{O} = 4.6V$	-0.64		-0.51	-0.88		-0.36		-
	Current	$V_{DD} = 10V, V_{O} = 9.5V$	-1.6		-1.3	-2.25		-0.9		mA
	(Note 3)	$V_{DD} = 15V, V_{O} = 13.5V$	-4.2		-3.4	-8.8		-2.4		
I _{IN}	Input Current	$V_{DD} = 15V, V_{IN} = 0V$		-0.10		-10 ⁻⁵	-0.10		-1.0	μА
		$V_{DD} = 15V, \ V_{IN} = 15V$		0.1		10 ⁻⁵	0.10		1.0	μΑ

Note 3: I_{OL} and I_{OH} are tested one output at a time.

AC Electrical Characteristics (Note 4)

CD4001BC: $T_A = 25$ °C, Input t_f ; $t_f = 20$ ns. $C_L = 50$ pF, $R_L = 200$ k. Typical temperature coefficient is 0.3% °C.

Symbol	Parameter	Conditions	Тур	Max	Units
t _{PHL}	Propagation Delay Time,	$V_{DD} = 5V$	120	250	
	HIGH-to-LOW Level	$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	35	70	
t _{PLH}	Propagation Delay Time,	$V_{DD} = 5V$	110	250	
	LOW-to-HIGH Level	$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	35	70	
t _{THL} , t _{TLH}	Transition Time	$V_{DD} = 5V$	90	200	
		$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	40	80	
C _{IN}	Average Input Capacitance	Any Input	5	7.5	pF
C _{PD}	Power Dissipation Capacity	Any Gate	14		pF

Note 4: AC Parameters are guaranteed by DC correlated testing.

AC Electrical Characteristics (Note 5)

CD4011BC: T_A= 25° C, Input t_r; t_f = 20 ns. C_L = 50 pF, R_L = 200k. Typical Temperature Coefficient is 0.3%/°C.

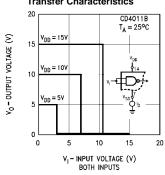
Symbol	Parameter	Conditions	Тур	Max	Units
t _{PHL}	Propagation Delay,	V _{DD} = 5V	120	250	
	HIGH-to-LOW Level	$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	35	70	
t _{PLH}	Propagation Delay,	$V_{DD} = 5V$	85	250	
	LOW-to-HIGH Level	$V_{DD} = 10V$	40	100	ns
		$V_{DD} = 15V$	30	70	
t _{THL} , t _{TLH}	Transition Time	$V_{DD} = 5V$	90	200	
		$V_{DD} = 10V$	50	100	ns
		$V_{DD} = 15V$	40	80	
C _{IN}	Average Input Capacitance	Any Input	5	7.5	pF
C _{PD}	Power Dissipation Capacity	Any Gate	14		pF

Note 5: AC Parameters are guaranteed by DC correlated testing.

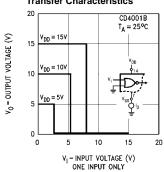
Typical Performance Characteristics

Typical

Typical Transfer Characteristics

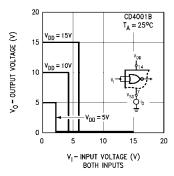


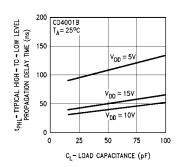
Typical Transfer Characteristics

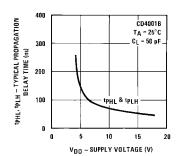


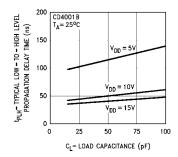
Typical Performance Characteristics (Continued)

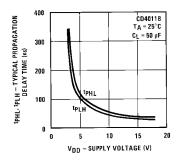
Typical Transfer Characteristics

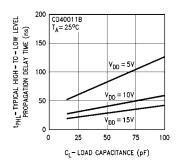




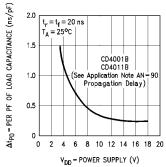


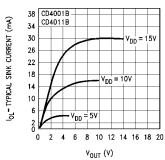


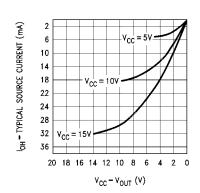


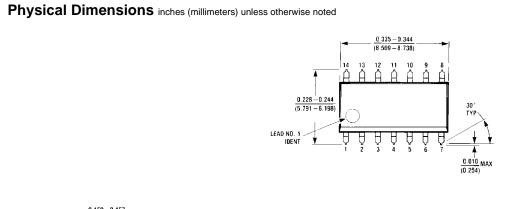


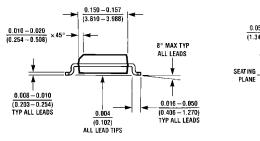
Typical Performance Characteristics (Continued) tthl, ttlh - TYPICAL TRANSITION TIME (ns) ^tPLH- TYPICAL LOW - TO - HIGH LEVEL PROPAGATION DELAY TIME (ns) 190 CD4001B 170 CD4011B V_{DD} = 5V V_{DD} = 10V V_{DD} = 15V 0 CL-LOAD CAPACITANCE (pF) CL-LOAD CAPACITANCE (pF)

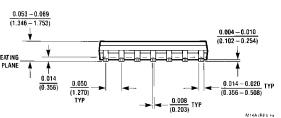




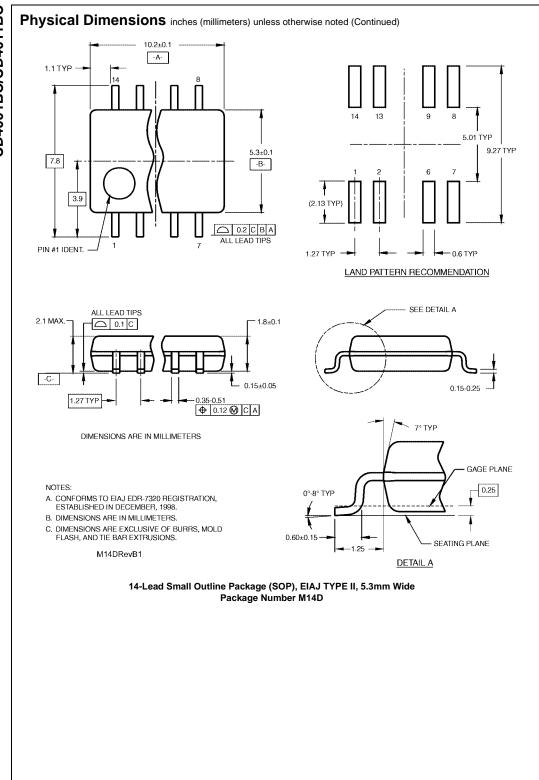




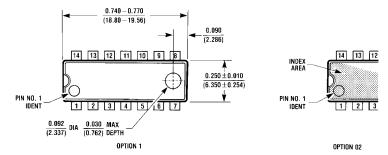


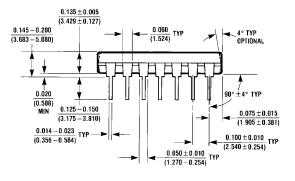


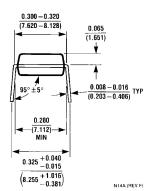
14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M14A



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)







14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

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